

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,859	YAO, JIE	
Examiner	Art Unit	
Fugene Lee	2815	

SEARCHED						
Subclass	Date	Examiner				
656	12/16/2005	EL				
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	Subclass	Subclass Date				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
searched EAST, USPAT, JPO, EPO	12/16/2005	EL			
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